## Application/Control No. Applicant(s)/Patent Under Reexamination 09/942,081 YEPISHIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2155 Oanh L. Duong **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 12-2000 709/224 Α US-6,157,940 Marullo et al. US-В С US-US-D US-Ε F US-US-G US-Н US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) ٧

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